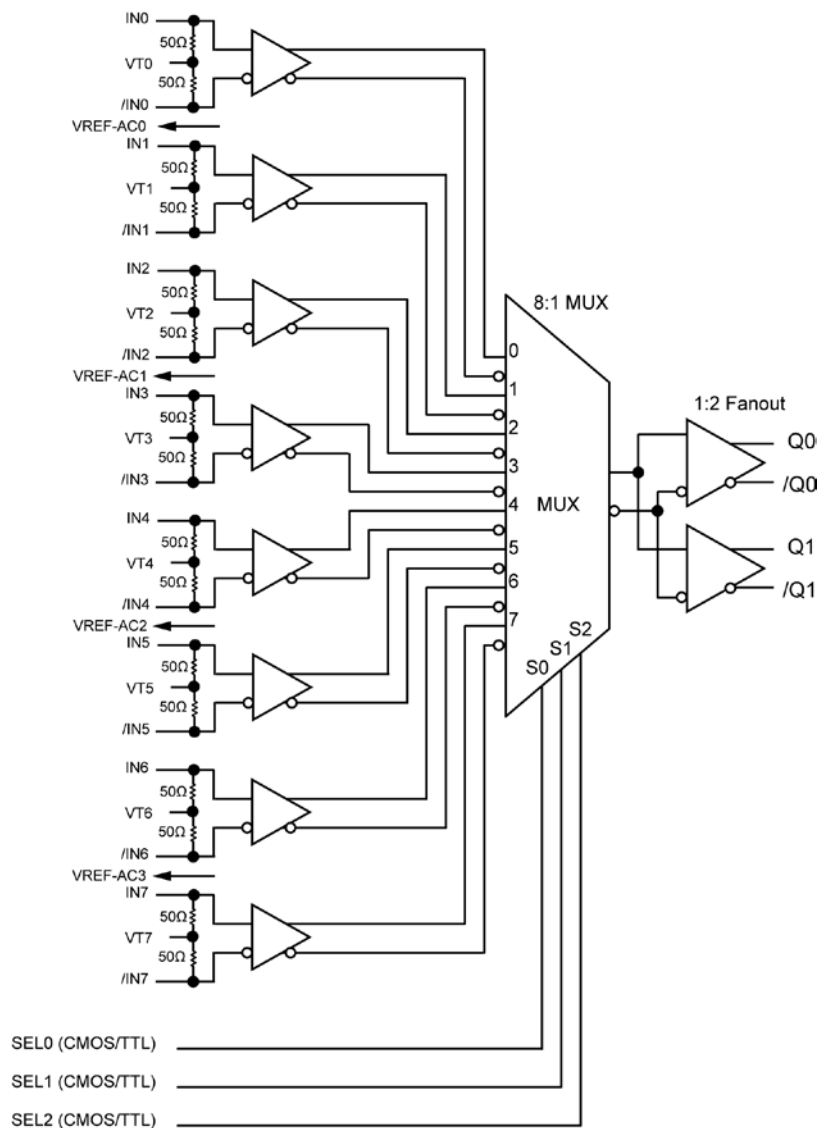


## Functional Block Diagram



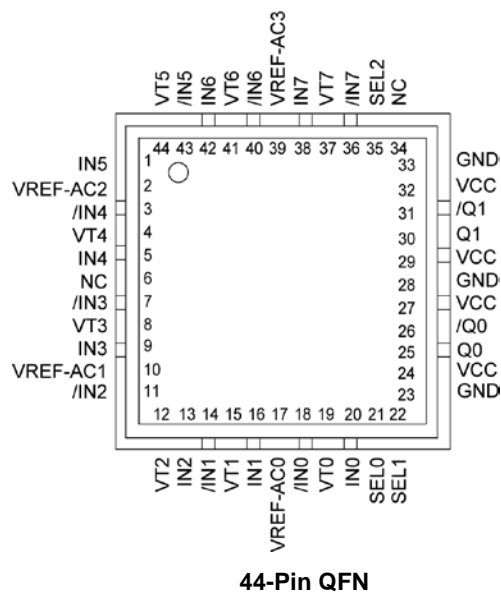
## Ordering Information<sup>(1)</sup>

Part Number	Package Type	Operating Range	Package Marking	Lead Finish
SY89859UMY	QFN-44	Industrial	SY89859U with Pb-Free bar-line indicator	Matte-Sn Pb-Free
SY89859UMYTR <sup>(2)</sup>	QFN-44	Industrial	SY89859U with Pb-Free bar-line indicator	Matte-Sn Pb-Free

### Notes:

1. Contact factory for die availability. Dice are guaranteed at  $T_A = 25^\circ\text{C}$ , DC Electricals only.
2. Tape and Reel.

## Pin Configuration



## Truth Table

SEL2	SEL1	SEL0	Q	/Q
L	L	L	IN0	/IN0
L	L	H	IN1	/IN1
L	H	L	IN2	/IN2
L	H	H	IN3	/IN3
H	L	L	IN4	/IN4
H	L	H	IN5	/IN5
H	H	L	IN6	/IN6
H	H	H	IN7	/IN7

## Pin Description

Pin Number	Pin Name	Pin Function
20, 18 16, 14 13, 11 9, 7 5, 3 1, 43 42, 40 38, 36	IN0, /IN0 IN1, /IN1 IN2, /IN2 IN3, /IN3 IN4, /IN4 IN5, /IN5 IN6, /IN6 IN7, /IN7	Differential Inputs: These input pairs are the differential signal inputs to the device. Inputs accept AC- or DC-coupled signals as small as 100mV (200mVpp). Each pin of a pair internally terminates to a VT pin through 50 $\Omega$ . Note that these inputs will default to an indeterminate state if left open. Please refer to the "Input Interface Applications" section for more details.
19, 15 12, 8 4, 44 41, 37	VT0, VT1 VT2, VT3 VT4, VT5 VT6, VT7	Input Termination Center-Tap: Each side of the differential input pair terminates to a VT pin. The VT pins provide a center-tap to a termination network for maximum interface flexibility. See "Input Interface Applications" section for more details. For a CML or LVDS inputs, the VT pin is left floating.
17 10 2 39	VREF-AC0 VREF-AC1 VREF-AC2 VREF-AC3	Reference Voltage: These outputs bias to $V_{CC}-1.2V$ . They are used when AC coupling the inputs (IN, /IN). For AC-coupled applications, connect VREF-AC to the VT pin and bypass with a 0.01 $\mu F$ low ESR capacitor to VCC. See "Input Interface Applications" section for more details.
21 22 35	SEL0 SEL1 SEL2	The single-ended TTL/CMOS-compatible inputs select the inputs to the multiplexer. Note that this input is internally connected to a 25k $\Omega$ pull-up resistor and will default to a logic HIGH state if left open. The threshold voltage is $V_{TH} = V_{CC}/2$ .
24, 27, 29, 32	VCC	Positive Power Supply. Bypass with 0.1 $\mu F$    0.01 $\mu F$ low ESR capacitors and place as close to each VCC pin as possible.
25, 26 30, 31	Q0, /Q0 Q1, /Q1	Differential Outputs: These 100K-compatible LVPECL output pairs are the outputs of the device. Unused output pairs may be left open. Each output is designed to drive 800mV into 50 $\Omega$ terminated to $V_{CC}-2V$ .
23, 28, 33	GND Exposed Pad	Ground. GND and exposed pad must both be connected to the same ground plane.

**Absolute Maximum Ratings<sup>(1)</sup>**

Supply Voltage ( $V_{CC}$ )	−0.5V to +4.0V
Input Voltage	
SEL0, SEL1, SEL2	−0.5V to $V_{CC}$
IN0, /IN0, IN1, /IN1, ... /IN7, /IN7	−0.5V to $V_{CC}$
LVPECL Output Current ( $I_{OUT}$ )	
Continuous	±50mA
Surge	±100mA
Termination Current	
Source or sink current	
VT0, VT1, VT2, ... VT7	±100mA
Input Current	
Source or sink current	
IN0, /IN0, IN1, /IN1, ... IN7, /IN7	±50mA
VREF Output Current	
VREF-AC0, VREF-AC1..., VREF-AC3	±2mA
Lead Temperature (soldering, 20 sec.)	+260°C
Storage Temperature ( $T_s$ )	−65°C to 150°C

**Operating Ratings<sup>(2)</sup>**

Supply Voltage ( $V_{CC}$ )	+2.375V to +2.625V
	+3.0V to +3.6V
Ambient Temperature ( $T_A$ )	−40°C to +85°C
Package Thermal Resistance <sup>(3)</sup>	
QFN ( $\theta_{JA}$ )	
Still-Air	24°C/W
QFN ( $\Psi_{JB}$ )	
Junction-to-Board	12°C/W

**DC Electrical Characteristics<sup>(4)</sup>**

$T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$ , unless otherwise stated.

Symbol	Parameter	Condition	Min	Typ	Max	Units
$V_{CC}$	Power Supply		2.375	2.5	2.625	V
			3.0	3.3	3.6	V
$I_{CC}$	Power Supply Current	No load, max. $V_{CC}$		60	85	mA
$R_{IN}$	Input Resistance (IN-to- $V_T$ )		45	50	55	$\Omega$
$R_{DIFF\_IN}$	Differential Input Resistance (IN-to-/IN)		90	100	110	$\Omega$
$V_{IH}$	Input High Voltage (IN, /IN)	Note 5	$V_{CC}-1.6$		$V_{CC}$	V
$V_{IL}$	Input Low Voltage (IN, /IN)		0		$V_{IH}-0.1$	V
$V_{IN}$	Input Voltage Swing (IN, /IN)	See Figure 1a.	0.1		1.7	V
$V_{DIFF\_IN}$	Differential Input Voltage Swing  IN-to-/IN	See Figure 1b.	0.2			V
$V_{T\_IN}$	IN-to- $V_T$ (IN, /IN)				1.28	V
$V_{REF\_AC}$	Output Reference Voltage		$V_{CC}-1.3$	$V_{CC}-1.2$	$V_{CC}-1.1$	V

**Notes:**

1. Permanent device damage may occur if absolute maximum ratings are exceeded. This is a stress rating only and functional operation is not implied at conditions other than those detailed in the operational sections of this data sheet. Exposure to absolute maximum ratings conditions for extended periods may affect device reliability.
2. The data sheet limits are not guaranteed if the device is operated beyond the operating ratings.
3. Package thermal resistance assumes exposed pad is soldered (or equivalent) to the devices most negative potential on the PCB.  $\theta_{JA}$  and  $\Psi_{JB}$  values are determined for a 4-layer board in still-air, unless otherwise stated.
4. The circuit is designed to meet the DC specifications shown in the above table after thermal equilibrium has been established.
5.  $V_{IH}$  (min) not lower than 1.2V.

## 100K LVPECL Output DC Electrical Characteristics<sup>(6)</sup>

$V_{CC} = +2.5V \pm 5\%$  or  $3.3V \pm 10\%$ ,  $R_L = 50\Omega$  to  $V_{CC}-2V$ ;  $T_A = -40^\circ C$  to  $+85^\circ C$ , unless otherwise stated.

Symbol	Parameter	Condition	Min	Typ	Max	Units
$V_{OH}$	Output HIGH Voltage (Q, /Q)		$V_{CC}-1.145$		$V_{CC}-0.895$	V
$V_{OL}$	Output LOW Voltage (Q, /Q)		$V_{CC}-1.945$		$V_{CC}-1.695$	V
$V_{OUT}$	Output Differential Swing	See Figure 1a.	550	800		mV
$V_{DIFF\_OUT}$	Differential Output Voltage Swing	See Figure 1b.	1100	1600		mV

## LVTTL/CMOS DC Electrical Characteristics<sup>(6)</sup>

$V_{CC} = +2.5V \pm 5\%$  or  $3.3V \pm 10\%$ ;  $T_A = -40^\circ C$  to  $+85^\circ C$ , unless otherwise stated.

Symbol	Parameter	Condition	Min	Typ	Max	Units
$V_{IH}$	Input HIGH Voltage		2.0			V
$V_{IL}$	Input LOW Voltage				0.8	V
$I_{IH}$	Input HIGH Current	$I_{IH} @ V_{IN} = V_{CC}$	-125		40	$\mu A$
$I_{IL}$	Input LOW Current	$I_{IL} @ V_{IN} = 0.5V$	-300			$\mu A$

### Note:

6. The circuit is designed to meet the DC specifications shown in the above table after thermal equilibrium has been established.

## AC Electrical Characteristics<sup>(7)</sup>

$V_{CC} = +2.5V \pm 5\%$  or  $3.3V \pm 10\%$ ;  $V_{IN} \geq 100mV$  (200mVpp);  $R_L = 50\Omega$  to  $V_{CC}-2V$ ;  $T_A = -40^\circ C$  to  $+85^\circ C$ , unless otherwise stated.

Symbol	Parameter	Condition	Min	Typ	Max	Units
$f_{MAX}$	Maximum Operating Frequency		2.5			Gbps
			2.5	3.5		GHz
$t_{pd}$	Differential Propagation Delay					
	IN-to-Q		360	475	640	ps
	SEL-to-Q		200	600	850	ps
$t_{pd}$ Tempco	Differential Propagation Delay	IN-to-Q		300		fs/ $^\circ C$
	Temperature Coefficient	SEL-to-Q		400		
$t_{SKEW}$	Output-to-Output Skew	Note 8	5		20	ps
	Part-to-Part Skew	Note 9			200	ps
$t_{JITTER}$	Data					
	Random Jitter (RJ)	Note 10			1	ps <sub>RMS</sub>
	Deterministic Jitter (DJ)	Note 11			10	ps <sub>PP</sub>
	Clock					
	Cycle-to-Cycle Jitter	Note 12			1	ps <sub>RMS</sub>
	Total Jitter (TJ)	Note 13			10	ps <sub>PP</sub>
	Adjacent Channel Crosstalk-induced Jitter	Note 14			0.7	ps <sub>RMS</sub>
$t_r, t_f$	Output Rise/Fall Time (20% to 80%)	At full output swing.	50	110	180	ps

### Notes:

- High-frequency AC-parameters are guaranteed by design and characterization.
- Output-to-output skew is measured between two different outputs under identical input transitions.
- Part-to-part skew is defined for two parts with identical power supply voltages at the same temperature and with no skew of the edges at the respective inputs.
- Random jitter is measured with a K28.7 character pattern, measured at  $<f_{MAX}$ .
- Deterministic jitter is measured at 2.5Gbps with both K28.5 and  $2^{23}-1$  PRBS pattern.
- Cycle-to-cycle jitter definition: the variation of periods between adjacent cycles,  $T_n - T_{n-1}$  where  $T$  is the time between rising edges of the output signal.
- Total jitter definition: with an ideal clock input of frequency  $<f_{MAX}$ , no more than one output edge in  $10^{12}$  output edges will deviate by more than the specified peak-to-peak jitter value.
- Crosstalk-induced jitter is defined as the added jitter that results from signals applied to two adjacent channels. It is measured at the output while applying two similar, differential clock frequencies that are asynchronous with respect to each other at the inputs.

## Single-Ended and Differential Swings

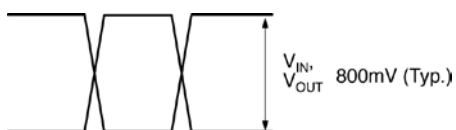


Figure 1a. Single-Ended Voltage Swing

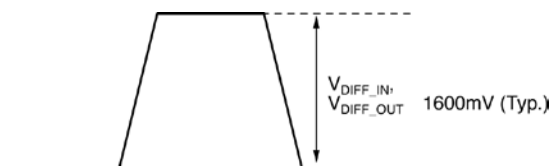
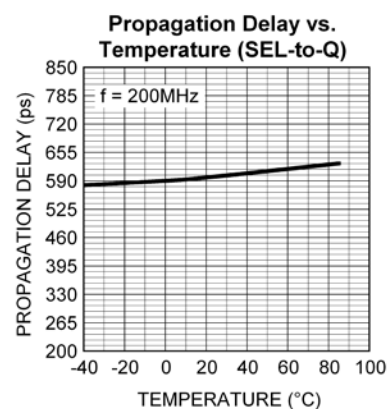
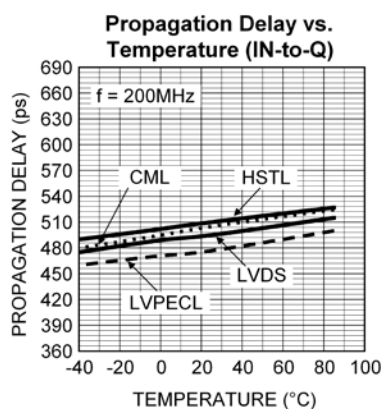
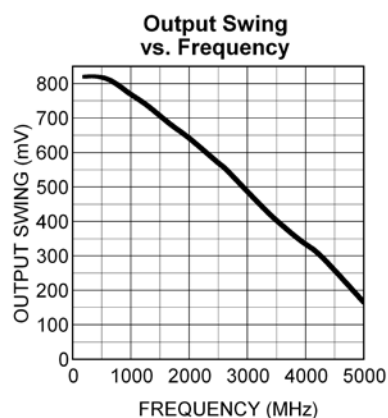


Figure 1b. Differential Voltage Swing

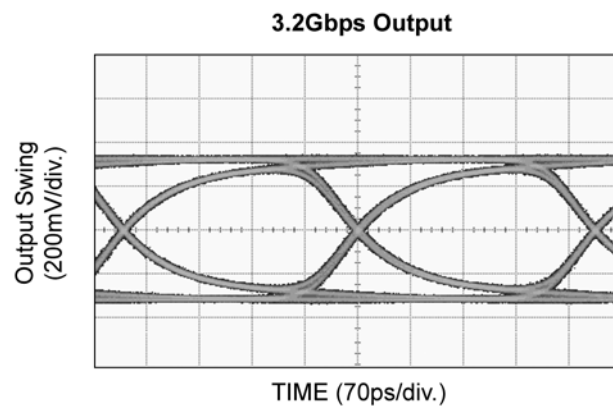
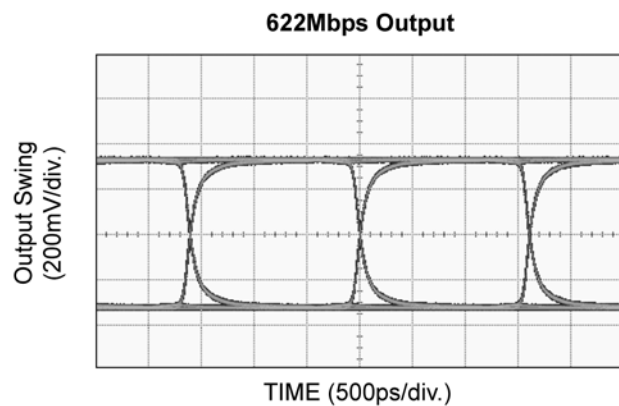
## Typical Operating Characteristics

$V_{CC} = 3.3V$ ,  $GND = 0$ ,  $V_{IN} = 100mV$  (200mVpp),  $R_L = 50\Omega$  to  $V_{CC}-2V$ ;  $T_A = 25^\circ C$ , unless otherwise stated.



## Functional Characteristics

$V_{CC} = 3.3V$ ,  $GND = 0$ ,  $V_{IN} = 100mV$  (200mVpp),  $R_L = 50\Omega$  to  $V_{CC}-2V$ ;  $T_A = 25^\circ C$ , unless otherwise stated.





## Input and Output Stages

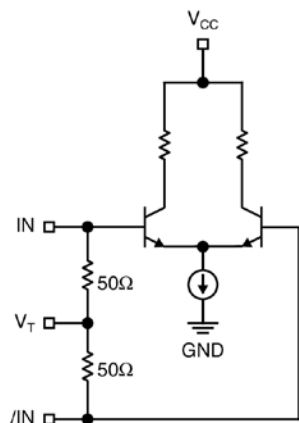


Figure 2a. Simplified Differential Input Stage

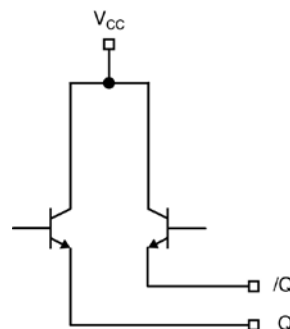


Figure 2b. Simplified LVPECL Output Stage

## Input Interface Applications

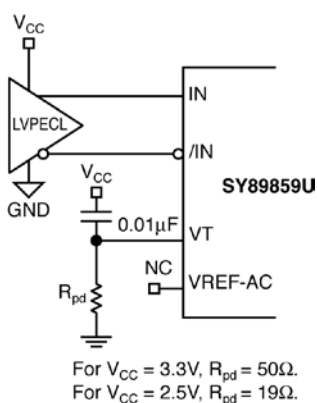


Figure 3a. LVPECL Interface (DC-Coupled)

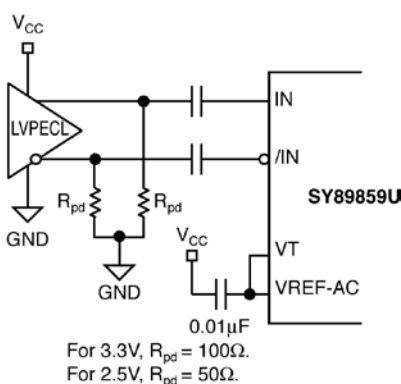
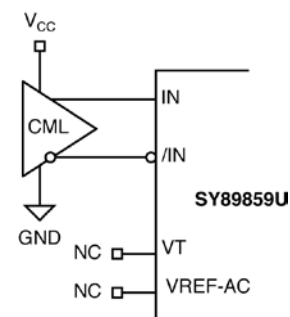


Figure 3b. LVPECL Interface (AC-Coupled)



Option: may connect  $V_T$  to  $V_{CC}$

Figure 3c. CML Interface (DC-Coupled)

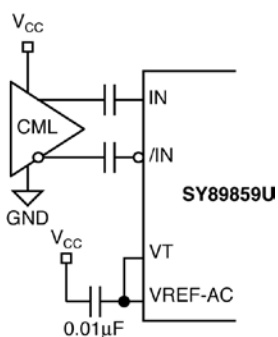


Figure 3d. CML Interface (AC-Coupled)

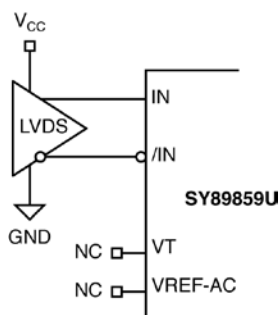
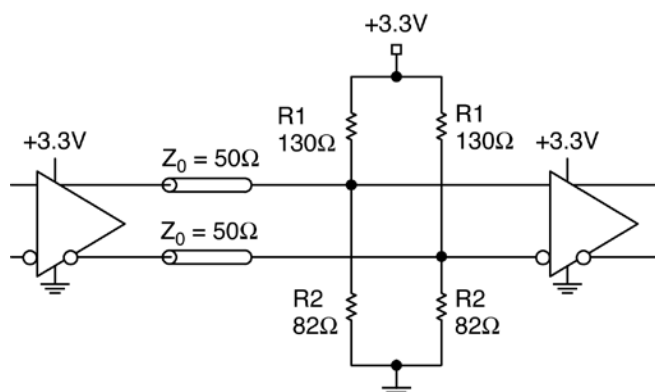


Figure 3e. LVDS Interface

## LVPECL Output Interface Applications

LVPECL has high input impedance, very low output (open emitter) impedance, and small signal swing which result in low EMI. LVPECL is ideal for driving 50 $\Omega$ - and 100 $\Omega$ -controlled impedance transmission lines. There are several techniques for terminating

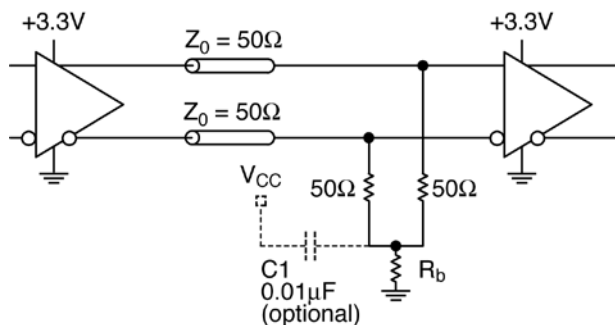
the LVPECL output including: Parallel Termination-Thevenin Equivalent, Parallel Termination (3-Resistor), and AC-Coupled Termination. Unused output pairs may be left floating. However, single-ended outputs must be terminated, or balanced.



**Figure 4a. Parallel Thevenin-Equivalent Termination**

**Note:**

For 2.5V system,  $R1 = 250\Omega$ ,  $R2 = 62.5\Omega$ .



**Figure 4b. Parallel Termination (3-Resistor)**

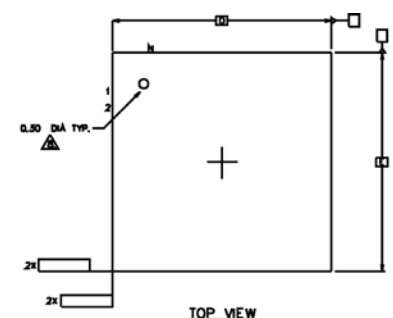
**Note:**

For 2.5V system,  $Rb = 19\Omega$ .

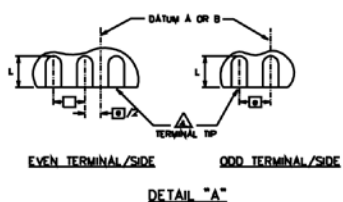
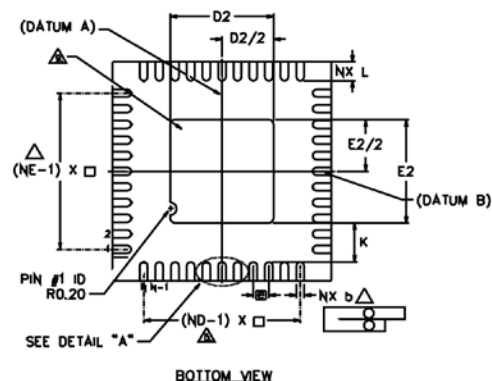
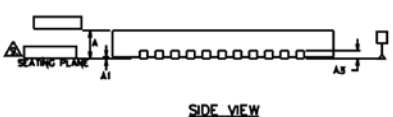
## Related Product and Support Documentation

Part Number	Function	Data Sheet Link
SY58037U	Ultra Precision 8:1 MUX with Internal Termination and 1:2 CML Fanout Buffer	<a href="http://www.micrel.com/product-info/products/sy58037u.shtml">http://www.micrel.com/product-info/products/sy58037u.shtml</a>
SY58038U	Ultra Precision 8:1 MUX with Internal Termination and 1:2 LVPECL Fanout Buffer	<a href="http://www.micrel.com/product-info/products/sy58038u.shtml">http://www.micrel.com/product-info/products/sy58038u.shtml</a>
SY58039U	Ultra Precision 8:1 MUX with Internal Termination and 1:2 400mV LVPECL Fanout Buffer	<a href="http://www.micrel.com/product-info/products/sy58039u.shtml">http://www.micrel.com/product-info/products/sy58039u.shtml</a>
HBW Solutions	New Products and Applications	<a href="http://www.micrel.com/product-info/products/solutions.shtml">www.micrel.com/product-info/products/solutions.shtml</a>

Package Information

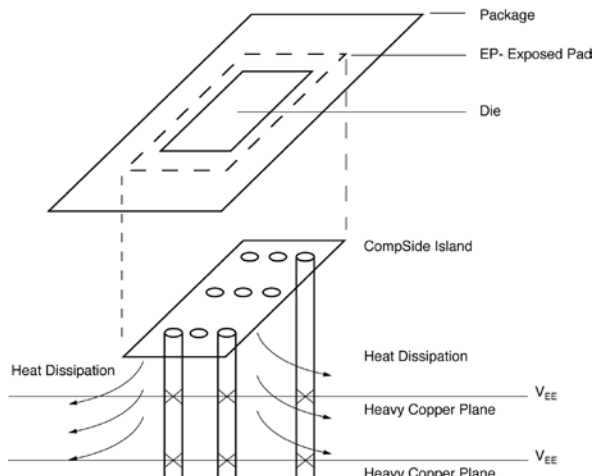


- NOTES :
- 1. DIMENSIONING AND TOLERANCING CONFORM TO ASME Y14.5M. - 1994.
  - 2. ALL DIMENSIONS ARE IN MILLIMETERS, 0 IS IN DEGREES.
  - 3. N IS THE TOTAL NUMBER OF TERMINALS.
  - △ DIMENSION b APPLIES TO METALLIZED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM TERMINAL TIP. IF THE TERMINAL HAS THE OPTIONAL RADIUS ON THE OTHER END OF THE TERMINAL, THE DIMENSION b SHOULD NOT BE MEASURED IN THAT RADIUS AREA.
  - △ ND AND NE REFER TO THE NUMBER OF TERMINALS ON EACH D AND E SIDE RESPECTIVELY.
  - 6. MAX. PACKAGE WARPAGE IS 0.05 mm.
  - 7. MAXIMUM ALLOWABLE BURRS IS 0.076 mm IN ALL DIRECTIONS.
  - △ PIN #1 ID ON TOP WILL BE LASER MARKED.
  - △ BILATERAL COPLANARITY ZONE APPLIES TO THE EXPOSED HEAT SINK SLUG AS WELL AS THE TERMINALS.
  - 10. THIS DRAWING CONFORMS TO JEDEC REGISTERED OUTLINE MO-220



SYMBOL	DIMENSIONS			NOTES
	MIN.	NOM.	MAX.	
□	0.50 BSC			
N	44			3
ND	11			△
NE	11			
L	0.55	0.60	0.65	
b	0.18	0.25	0.30	△
D2	3.20	3.30	3.40	
E2	3.20	3.30	3.40	
D	7.00 BSC			
E	7.00 BSC			
A	0.80	0.85	1.00	
A1	0.00	0.02	0.05	
K	0.20 MIN.			
θ	0	—	12	2

44-Pin QFN (QFN-44)



PCB Thermal Consideration for 44-Pin QFN™ Package  
(Always solder, or equivalent, the exposed pad to the PCB)

- Package Notes:
- 1. Package meets Level 2 qualification.
  - 2. All parts are dry-packaged before shipment.
  - 3. Exposed pads must be soldered to a ground for proper thermal management.

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